

<b>Notice of References Cited</b>	Application/Control No. 09/761,240		Applicant(s)/Patent Under Reexamination BAUER ET AL.	
	Examiner Johannes P Mondt		Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,684,323	11-1997	Tohyama, Shigeru	257/363
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	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
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	M	US-			

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*	N	DE3917769A1 (IDS 7/19/02)	12-1990	Germany	Gerstenmaier et al.	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.